

<b>Notice of References Cited</b>	Application/Control No. 10/559,923		Applicant(s)/Patent Under Reexamination TSUKADA ET AL.	
	Examiner Alexander O. Williams		Art Unit 2826	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,911,728 B2	06-2005	Ishikawa et al.	257/706
*	B	US-2007/0183127 A1	08-2007	ISHIKAWA et al.	361/709
*	C	US-7,161,807 B2	01-2007	Ishikawa et al.	361/708
*	D	US-2007/0284731 A1	12-2007	Atsumi et al.	257/706
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	2002-043482	02-2002	Japan	Ishikawa et al.	
	O	2004-253736	09-2004	Japan	Ishikawa et al.	
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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